

FINAL VERSION

VERSION FINALE

**Measurement procedures for materials used in photovoltaic modules –
Part 1-4: Encapsulants – Measurement of optical transmittance and calculation
of the solar-weighted photon transmittance, yellowness index, and UV cut-off
wavelength**

**Procédures de mesure des matériaux utilisés dans les modules
photovoltaïques –
Partie 1-4: Encapsulants – Mesurage du facteur de transmission optique
et calcul du facteur de transmission photonique à pondération solaire,
de l'indice de jaunissement et de la fréquence de coupure des UV**

CONTENTS

FOREWORD	3
1 Scope	5
2 Normative references	5
3 Terms and definitions	6
4 Principle	7
5 Apparatus	7
6 Test specimens	7
6.1 Nominal (and unweathered) transmittance to the cell	7
6.2 Weathering studies	8
6.3 Glass for superstrates/substrates	9
6.4 Number of specimens	9
6.5 Conditioning of specimens	9
7 Measurement procedure	9
7.1 General	9
7.2 Specimen preparation	10
7.3 Instrument calibration (baseline measurements)	10
7.4 Specimen measurements	10
7.5 Witness measurements	10
7.5.1 Witness specimen(s)	11
7.5.2 Procedure for the witness specimen prior to the test specimen(s)	11
7.5.3 Measurement of the test specimen(s)	11
7.5.4 Procedure for the witness specimen after the test specimen(s)	11
8 Calculation and expression of results	11
8.1 Post-processing of data	11
8.2 Calculation of weighted transmittance	12
8.3 Calculation of the Yellowness Index (YI)	12
8.4 Calculation of the UV cut-off wavelength	12
9 Uncertainty of measurements	13
10 Test report	13
Annex A (informative) Advanced analysis of transmittance (absorption coefficients)	15
Annex B (informative) Applying the quantum efficiency of a specific cell technology	17
Bibliography	19
Table 1 Details of the solar weight transmittance parameters	12

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**MEASUREMENT PROCEDURES FOR MATERIALS
USED IN PHOTOVOLTAIC MODULES –**

**Part 1-4: Encapsulants – Measurement of optical transmittance and
calculation of the solar-weighted photon transmittance,
yellowness index, and UV cut-off wavelength**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International governmental and non-governmental organizations liaising with the IEC also participate in this preparatory work. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters expressed, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

This consolidated version of the official IEC Standard and its amendment has been prepared for user convenience.

IEC 62788-1-4 edition 1.1 contains the first edition (2016-09) [documents 82/1148/FDIS and 82/1165/RVD] and its amendment 1 (2020-10) [documents 82/1767/FDIS and 32/1791/RVD].

This Final version does not show where the technical content is modified by amendment 1. A separate Redline version with all changes highlighted is available in this publication.

International Standard IEC 62788-1-4 has been prepared by IEC technical committee 82: Solar photovoltaic energy systems.

A list of all parts in the IEC 62788 series, published under the general title *Measurement procedures for materials used in photovoltaic modules*, can be found on the IEC website.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

MEASUREMENT PROCEDURES FOR MATERIALS USED IN PHOTOVOLTAIC MODULES –

Part 1-4: Encapsulants – Measurement of optical transmittance and calculation of the solar-weighted photon transmittance, yellowness index, and UV cut-off wavelength

1 Scope

This part of IEC 62788 provides a method for measurement of the optical transmittance of encapsulation materials used in photovoltaic (PV) modules. The standardized measurements in this procedure quantify the expected transmittance of the encapsulation to the PV cell. Subsequent calculation of solar-weighted transmittance allows for comparison between different materials. The results for unweathered material may be used in an encapsulation manufacturer's datasheets, in manufacturer's material or process development, in manufacturing quality control (material acceptance), or applied in the analysis of module performance.

This measurement method can also be used to monitor the performance of encapsulation materials after weathering, to help assess their durability. The standardized measurements are intended to examine an interior region within a PV module, e.g., without the effects of oxygen diffusion at the periphery of the cells. Subsequent calculation of yellowness index allows for quantification of durability and consideration of appearance. The change in transmittance, yellowness index, and ultraviolet (UV) cut-off wavelength may be used by encapsulation or module manufacturers to compare the durability of different materials.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60904-3, *Photovoltaic devices – Part 3: Measurement principles for terrestrial photovoltaic (PV) solar devices with reference spectral irradiance data*

ISO 291:2008, *Plastics – Standard atmospheres for conditioning and testing*

ISO 11664-1:2007, *Colorimetry – Part 1: CIE standard colorimetric observers*

ISO 11664-2:2007, *Colorimetry – Part 2: CIE standard illuminants*

ISO 13468-2:1999, *Plastics – Determination of the total luminous transmittance of transparent materials – Part 2: Double-beam instrument*

ISO 17223:2014, *Plastics – Determination of yellowness index and change in yellowness index*

ASTM E424-71:2007, *Standard test methods for solar energy transmittance and reflectance (Terrestrial) of sheet material*